



A Case Study Statistical Process Control

Utilizing Statistical Process Control (SPC) techniques, the FZU-48 fuze initiator (for the FMU-139 bomb fuze) program in the Tactical Electronics Division (TED) moved quickly and smoothly from the design stage to the full-scale high-volume production stage. Virtually all phases of product manufacturability (design, assembly, tooling, machines, test equipment and inspection) used SPC and problem-solving techniques (PST). The result was a system capable of delivering excellent product quality and achieving a high-volume production output.

All machinery, tooling and fixtures were carefully designed with a zero defect approach. A team of engineers trained in SPC carefully reviewed the design prints in a brainstorming/failure analysis and correction mode to minimize design flaws during production. After the machines, test equipment, tools and other peripherals, arrived, they underwent carefully planned machine capability studies.

The machine capability studies comprised two phases. First, a capability index (Cpk) and a capability potential (Cp) were calculated for all critical variables, followed by tests for statistical control. Next, reduction of variation was performed when the capability index failed to meet the planned target Cpk index of greater than 1.0 (factored by a four sigma spread). During the reduction of variation, variables contributing to variation were identified and either removed or reduced to a controllable level.

The capability studies helped to predict with a level of certainty the performance of the equipment and to collectively determine whether the process had sufficiently low variability to meet process specifications. It also served to uncover areas of potential problems before production and encouraged efforts to prevent production of non conformance products.

Seventy percent of the machines (test equipment, tools, etc.) had a capability index Cpk higher than 2.0 (planned goal Cpk) and the other 30 percent exceeded a Cpk of 1.0. The Final Lanyard Pin Press experienced seven cycles of machine capability studies and redesign before it was considered unsuitable for production and replaced by a new machine.

During the various stages of production, many problems arose and were aggressively corrected utilizing PST and SPC techniques. PST techniques included brainstorming sessions, cause-and-effect diagrams and Pareto diagrams. SPC techniques included variable search and statistically designed single-factor and full factorial experiments.

Ishikawa (cause-and-effect) diagrams, Design of Experiments (DOE) and brainstorming were used to solve complex problems such as the epoxy leakage through the end cap towers, reducing the defective rate from 68 percent to less than .1 percent. The use of DOE was also effective in correcting the problem of high shearing force for lanyard separation which failed to shear at a force of 148 ± 20 lbs-f. A two by three (three factors, two levels) full factorial experiment was designed and conducted yielding accountability for 96 percent of the variation. The standard deviation of the shearing force prior to experimentation was 34 and was successfully reduced to 3.3.

After the completion of the first 115 deliverable FZU-48 units, an unforeseen design flaw resulted in failure of the First Article Acceptance Test. Aggressive utilization of PST and DOE techniques by a team comprised of Design, Manufacturing, Quality Assurance and Test engineers corrected the problem.



MOTOROLA INC.

Government Electronics Group

In a period of five weeks, fourteen consecutive statistically designed experiments were conducted, leading to product design changes and reduction of product performance variability. The standard deviation of the cover opening force of the unit prior to experimentation was 34.58. It was reduced to 4.70, thereby achieving a Cpk equal to 2.20 and exceeding Motorola's Six Sigma design objective (see chart).

Since production began in early August 1987, the FZU-48 program has increased its production by ten times, from 50 units per day initially to 550 units per day. During this period, eight consecutive Lot Acceptance Tests (LATs) have been conducted and passed. Of all the units tested during the LATs, one unit has failed. That unit was later found to have a piece part out of tolerance which caused the failure.

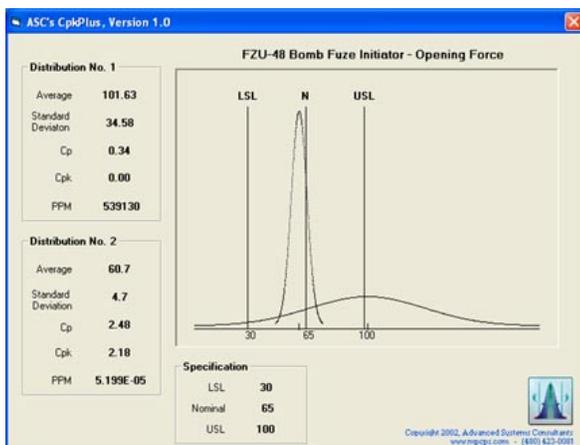
The team of SPC experts responsible for applying the SPC techniques consisted of Adi K. Bhote, TED SPC coordinator for the Manufacturing Board Assembly Area; Jim Blanden, TED Manufacturing SPC specialist; and Mario Perez-Wilson, Divisional SPC manager, Small Signal & Sensor Products Division, Semiconductor Products Sector, and former SPC coordinator for the FZU-48 and FMU-139 programs. Contributing their engineering expertise and support were Jim Gardner, senior test equipment engineer, Ron Meyer, lead design engineer, and Pete Rendek, lead design engineer. Management commitment and support to implement SPC from the design stages was carried out by Kevin Mulroy, then a Quality Assurance team member, and Ray Beliveau, Manufacturing team member.

"The FZU-48 program is probably the first program in Motorola that utilized SPC techniques from the very beginning. This program has been quoted by our customer as being their first program to go from design to full-scale production in a fast and smooth manner. The major ingredient to this success has been the implementation of SPC," Mario said.

No blueprint exists for the successful implementation of SPC in a production system. However, the SPC techniques used on the FZU-48 program can facilitate a smooth transition from design to full-scale production on other programs if they are performed as early as possible prior to production.

On the FZU-48 program, potential problems were: 1) detected using machine/process capability studies 2) statistically quantified using descriptive statistics and probabilities and 3) statistically corrected with statistically designed experiments. After implementation, the corrections were statistically validated.

The end result? Guaranteed high quality output.



(Information provided by Mario Perez Wilson,
Divisional Statistical Methods Engineering Manager,
Motorola Semiconductor Product Sector
Small Signal & Sensor Products Division)

January 21, 1988